

**Search Notes**

Application/Control No.

09/836,397

Examiner

Sargon N. Nano

Applicant(s)/Patent under  
Reexamination

CHAN, HARK C.

Art Unit

2157

**SEARCHED**

Class	Subclass	Date	Examiner
709	218 , 219 227 , 228	12/2/2005	SN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST (see report)	12/2/2005	SN